

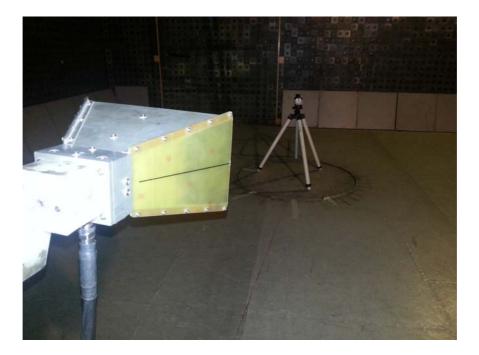
Photograph No.1 Setup for spurious emission field strength measurements in the anechoic chamber below 30 MHz



Photograph No.2 Setup for carrier and spurious emission field strength measurements in the anechoic chamber in 30 – 1000 MHz range



Photograph No.3 Setup for spurious emission field strength and OBW measurements in the anechoic chamber in 1 - 18 GHz range



Photograph No.4 Setup for spurious emission field strength measurements at the OATS in 18 - 25 GHz range





Photograph No.5 Setup for occupied bandwidth measurements